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Application/Control No.	Applicant(s)/Patent Reexamination	under ,
10/624,234	RITLAND, STEPH	EN
Examiner	Art Unit	
John Kim	3733	

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Class	Subclass	Date	Examiner
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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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Inventor's name search	6/15/2006	JK
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